

<b>Notice of References Cited</b>	Application/Control No. 10/823,713		Applicant(s)/Patent Under Reexamination KOO ET AL.	
	Examiner A. Sefer		Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,506,635	01-2003	Yamazaki et al.	438/148
*	B	US-2003/0062499	04-2003	Yamazaki, Shunpei	251/200
	C	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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